Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/053,585	NAYA ET AL.
Examiner	Art Unit
Christopher L. Chin	1641

SEARCHED					
Subclass	Date	Examiner			
Search	10/15/2005	СС			
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	Subclass	Subclass Date Search 10/15/2005			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
EAST search - see search report	10/15/2005	cc
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